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ON Semiconductor®

# FDD120AN15A0-F085

## N-Channel Power Trench® MOSFET

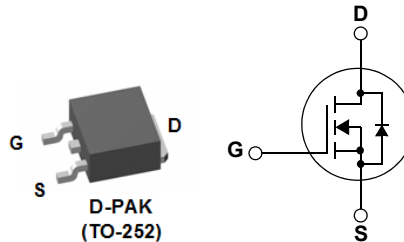
150V, 14A, 120mΩ

### Features

- Typ  $r_{DS(on)} = 90.5m\Omega$  at  $V_{GS} = 10V, I_D = 4A$
- Typ  $Q_{g(tot)} = 11.3nC$  at  $V_{GS} = 10V, I_D = 4A$
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

### Applications

- Automotive Engine Control
- Powertrain Management
- Solenoid and Motor Drivers
- Integrated Starter/alternator
- Primary Switch for 12V Systems



### MOSFET Maximum Ratings $T_J = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain to Source Voltage	150	V
$V_{GS}$	Gate to Source Voltage	$\pm 20$	V
$I_D$	Drain Current - Continuous ( $V_{GS}=10$ ) (Note 1)	$T_C = 25^\circ C$	14
	Pulsed Drain Current	$T_C = 25^\circ C$	See Figure 4
$E_{AS}$	Single Pulse Avalanche Energy (Note 2)	122	mJ
$P_D$	Power Dissipation	65	W
	Derate above $25^\circ C$	0.43	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature	-55 to + 175	$^\circ C$
$R_{\theta JC}$	Thermal Resistance Junction to Case	2.3	$^\circ C/W$
$R_{\theta JA}$	Maximum Thermal Resistance Junction to Ambient (Note 3)	52	$^\circ C/W$

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD120AN15A0	FDD120AN15A0-F085	D-PAK(TO-252)	330mm	12mm	2500 units

#### Notes:

- 1: Current is limited by bondwire configuration.
- 2: Starting  $T_J = 25^\circ C, L = 27mH, I_{AS} = 3A, V_{DD} = 100V$  during inductor charging and  $V_{DD} = 0V$  during time in avalanche
- 3:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

FDD120AN15A0-F085 N-Channel Power Trench® MOSFET

## Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$B_{V_{DSS}}$	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	150	-	-	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS} = 150\text{V}, T_J = 25^\circ\text{C}$	-	-	1	$\mu\text{A}$
		$V_{GS} = 0\text{V}, T_J = 175^\circ\text{C}(\text{Note } 4)$	-	-	1	mA
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	2.0	3.0	4.0	V
$r_{DS(on)}$	Drain to Source On Resistance	$I_D = 4\text{A}, T_J = 25^\circ\text{C}$	-	90.5	120	$\text{m}\Omega$
		$V_{GS} = 10\text{V}, T_J = 175^\circ\text{C}(\text{Note } 4)$	-	227	302	$\text{m}\Omega$

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$	-	743	-	pF
$C_{oss}$	Output Capacitance		-	85	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	20	-	pF
$R_g$	Gate Resistance	$f = 1\text{MHz}$	-	3.4	-	$\Omega$
$Q_{g(ToT)}$	Total Gate Charge at 10V	$V_{GS} = 0$ to 10V	-	11.3	14	nC
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0$ to 2V				
$Q_{gs}$	Gate to Source Gate Charge	$V_{DD} = 75\text{V}, I_D = 4\text{A}$	-	3.1	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		-	2.6	-	nC

### Switching Characteristics

$t_{on}$	Turn-On Time	$V_{DD} = 75\text{V}, I_D = 4\text{A}, V_{GS} = 10\text{V}, R_{GEN} = 24\Omega$	-	-	31	ns
$t_{d(on)}$	Turn-On Delay Time		-	14	-	ns
$t_r$	Rise Time		-	13	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	34	-	ns
$t_f$	Fall Time		-	15	-	ns
$t_{off}$	Turn-Off Time		-	-	59	ns

### Drain-Source Diode Characteristics

$V_{SD}$	Source to Drain Diode Voltage	$I_{SD} = 4\text{A}, V_{GS} = 0\text{V}$	-	-	1.25	V
		$I_{SD} = 2\text{A}, V_{GS} = 0\text{V}$	-	-	1.2	V
$T_{rr}$	Reverse Recovery Time	$I_F = 4\text{A}, dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	46	60	ns
$Q_{rr}$	Reverse Recovery Charge	$V_{DD} = 120\text{V}$	-	94	108	nC

#### Notes:

4: The maximum value is specified by design at  $T_J = 175^\circ\text{C}$ . Product is not tested to this condition in production.

### Typical Characteristics

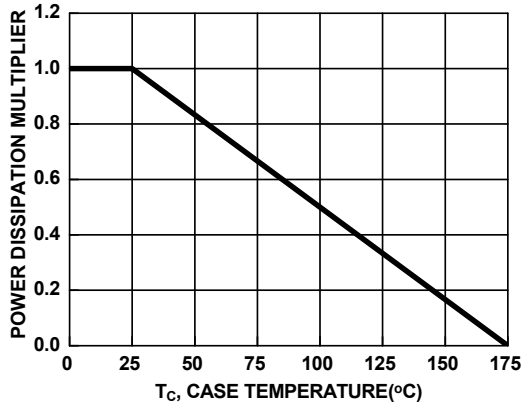


Figure 1. Normalized Power Dissipation vs Case Temperature

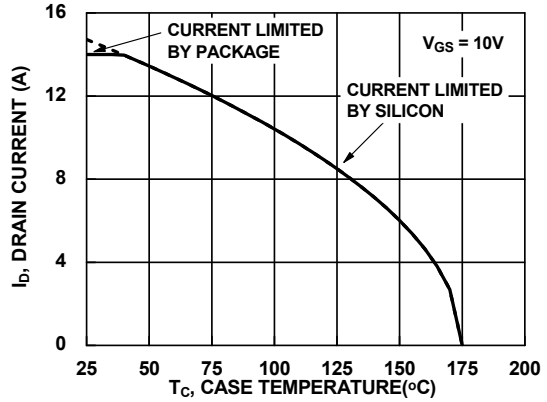


Figure 2. Maximum Continuous Drain Current vs Case Temperature

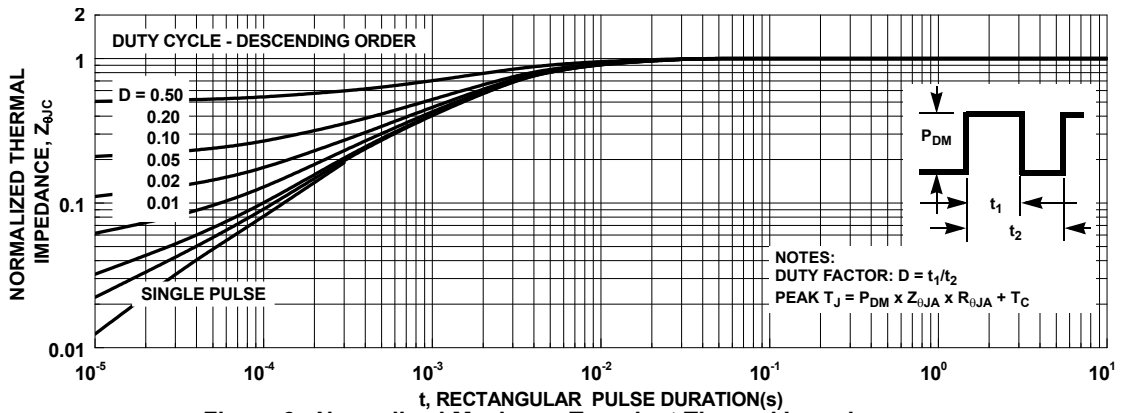


Figure 3. Normalized Maximum Transient Thermal Impedance

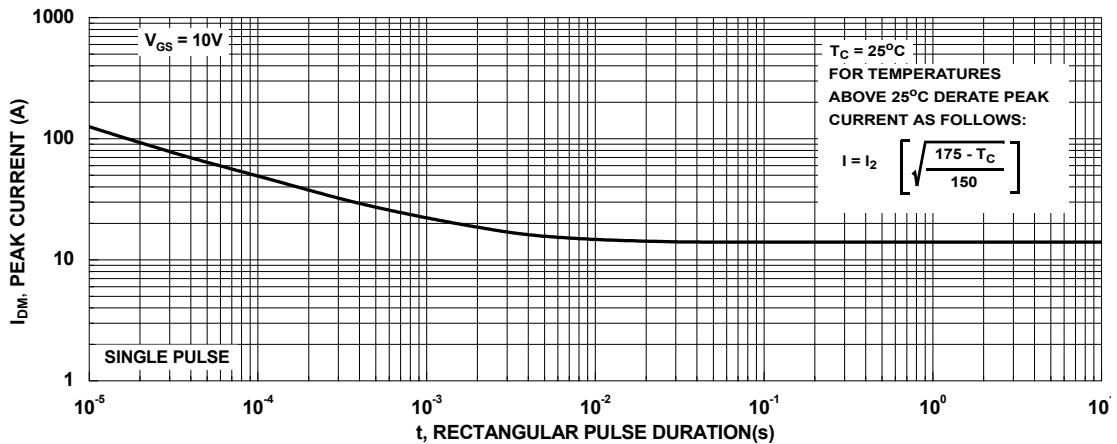


Figure 4. Peak Current Capability

## Typical Characteristics

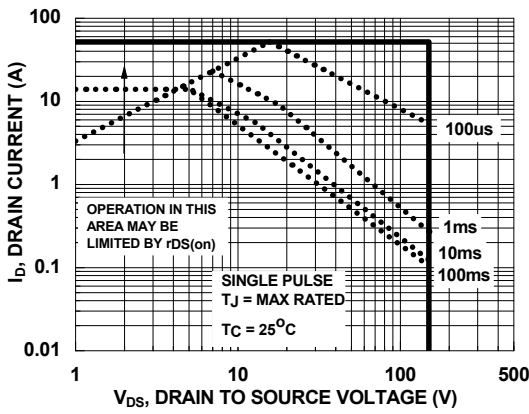
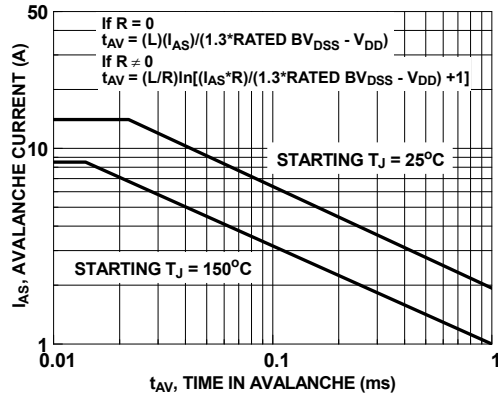


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to ON Semiconductor Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability

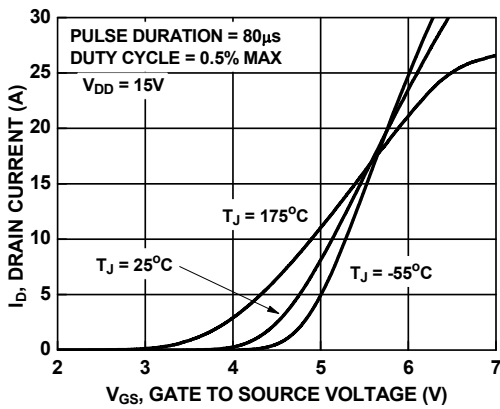


Figure 7. Transfer Characteristics

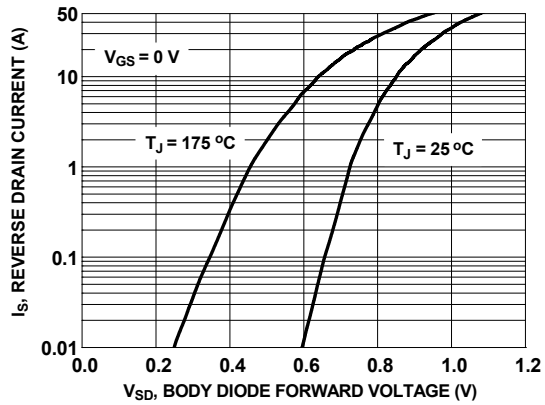


Figure 8. Forward Diode Characteristics

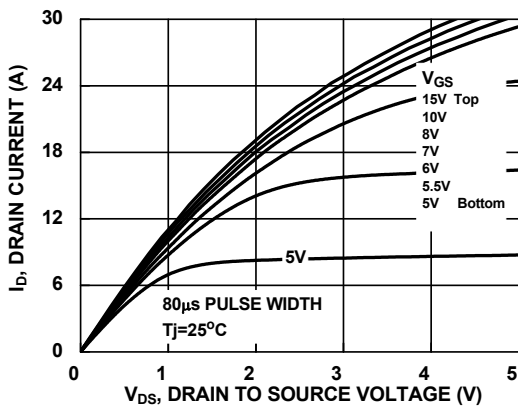


Figure 9. Saturation Characteristics

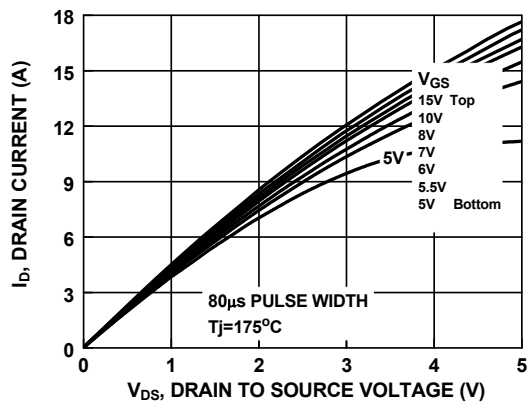
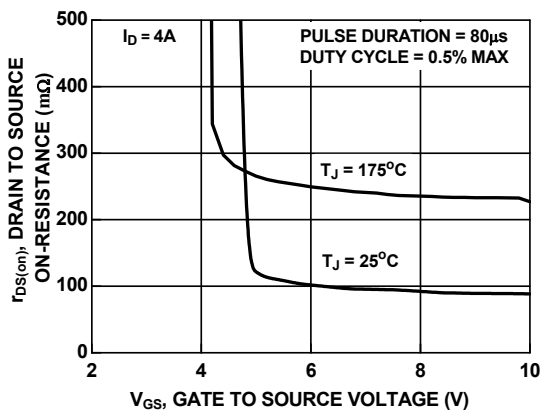
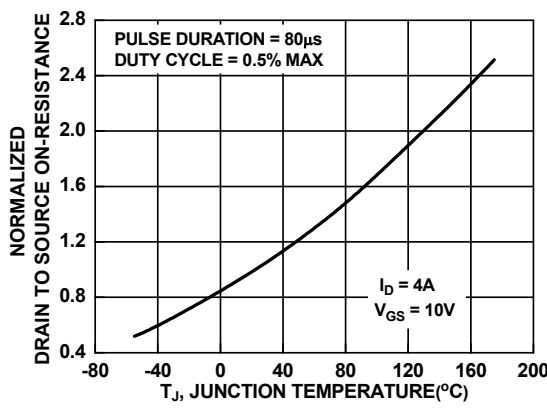


Figure 10. Saturation Characteristics

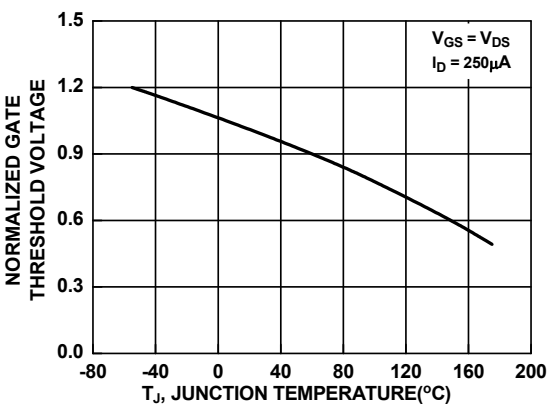
**Typical Characteristics**



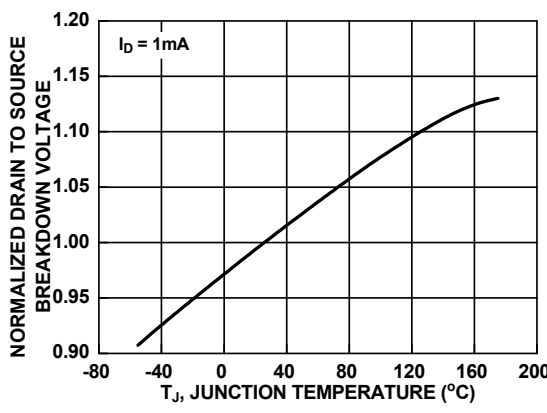
**Figure 11.  $R_{dson}$  vs Gate Voltage**



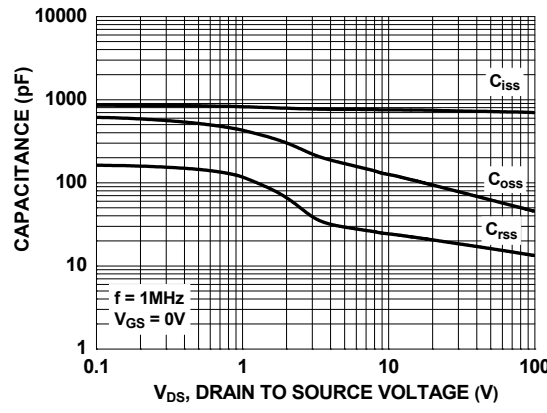
**Figure 12. Normalized  $R_{dson}$  vs Junction Temperature**



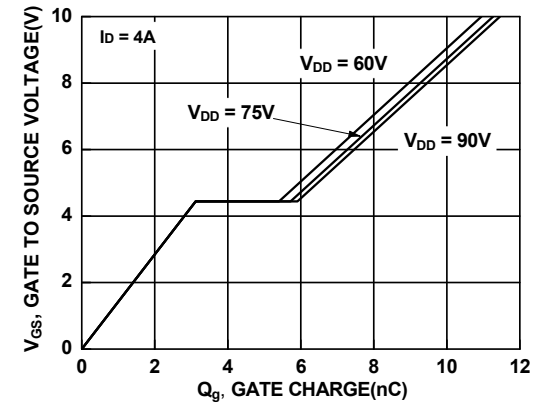
**Figure 13. Normalized Gate Threshold Voltage vs Temperature**



**Figure 14. Normalized Drain to Source Breakdown Voltage vs Junction Temperature**



**Figure 15. Capacitance vs Drain to Source Voltage**



**Figure 16. Gate Charge vs Gate to Source Voltage**

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